

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION: **DELATTRE, Cyril, et al**

GROUP ART UNIT: TBA

SERIAL NUMBER: 10/576,342

EXAMINER: TBA

FILED: April 18, 2006

FOR: **PROCESS FOR DISTRIBUTING DROPS OF A LIQUID OF INTEREST ONTO A SURFACE**

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. 1.97

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Applicant(s) wish to disclose the following information.

REFERENCES

- The Applicant(s) wish to make of record the references listed on the attached PTO/ SB/08. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check is attached in the amount required under 37 CFR § 1.17(p).

RELATED CASES

- Attached is a list of applicant's pending applications or issued patents which may be related to the present application. A copy of the patent(s) is attached along with PTO/ SB/08.
- A check is attached in the amount required under 37 CFR § 1.17(p).

CERTIFICATION

The undersigned certifies that

- each item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- no item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR § 1.56(c) more than three months prior to the filing of this statement.

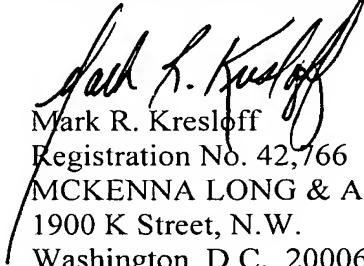
PETITION

Applicant(s) hereby request consideration of the attached information. A check is attached in the amount of the Petition fee required under 37 CFR § 1.17(i)(1).

DEPOSIT ACCOUNT

Please charge any additional fees for the papers being filed herewith and for which no check is enclosed herewith, or credit any overpayment to deposit account No. 50-0911. A duplicate copy of this sheet is enclosed.

Respectfully submitted,



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Date: December 28, 2006

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Substitute for form 1449/PTO				<i>Complete if Known</i>	
				Application Number	10/576,342
				Filing Date	April 18, 2006
				First Named Inventor	DELATTRE, Cyril
				Art Unit	TBA
				Examiner Name	TBA
Sheet	1	of	2	Attorney Docket Number	10404.038.00-US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
AA		6,143,496 •	11-07-2000	BROWN, ET AL.	
AB		6,210,894 B1 •	04-03-2001	BRENNAN	
AC		6,565,813 B1 •	05-20-2003	GARYANTES	
AD		6,040,193 •	03-21-2000	FODOR, ET AL.	
AE					
AF					

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			
BA		WO 02/41992 A2 •	05-30-2002	SIEMENS AKTIENGESELLSCHAFT	
BB		WO 03/059518 A1 •	07-24-2003	UNIVERSITY COLLEGE CORK-NATIONAL UNIVERSITY OF IRELAND, CORK	
BC		WO 02/16023 A2 •	02-28-2002	PROTO-GENE LABORATORIES, INC.	
BD		WO 99/03684 •	01-28-1999	CAMBRIDGE SENSORS LIMITED	
BE		WO 00/36145 (w/Abstract) •	06-22-2000	COMMISSARIAT ENERGIE ATOMIQUE	
BF		WO 02/090573 A2 (w/Abstract) •	11-14-2002	INFINEON TECHNOLOGIES AG	
BG		FR 2 818 662 A1	12-22-2000	COMMISSARIAT A L'ENERGIE ATOMIQUE	
BH		EP 0 561 722 A1	03-17-1993	BIO MERIEUX	
BI					
BJ					

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Examiner Signature	Date Considered
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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
	CA	Azek, F., et al., Hybridization Assay at a Disposable Electrochemical Biosensor for the Attomole Detection of Amplified Human Cytomegalovirus DNA, Analytical Biochemistry 284, 2000, pp. 107-113			
	CB	Lee, J., et al., Electrowetting and electrowetting-on-dielectric for microscale liquid handling, Sensors and Actuators A 95, 2002, pp. 259-268			
	CC	Bratten, C.D., et al., Micromachining Sensors for Electrochemical Measurement in Subnanoliter Volumes, Analytical Chemistry, Vol. 69, No. 2, 1997, pp. 253-258			
	CD	Yang, M., et al., Covalent Immobilization of Oligonucleotides on Modified Glass/Silicon Surfaces for Solid-phase DNA Hybridization and Amplification, The Chemical Society of Japan, 1998, pp. 257-258			
	CE	Boncheva, M., et al., Design of Oligonucleotide Arrays at Interfaces; American Chemical Society, 1999 pp. 4317-4320			
	CF	Jansen, H., et al., The black silicon method: a universal method for determining the parameter setting of a fluorine-based reactive ion etcher in deep silicon trench etching with profile control, J. Micromech. Microeng. 5, 1995, pp. 115-120			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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